

IV3Q12035D7Z- Gen3 1200V 35mΩ Automotive SiC MOSFET

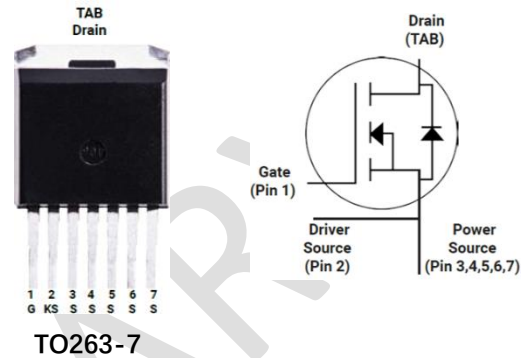
Features

- 3rd Generation SiC MOSFET Technology with +15~+18V gate drive
- High blocking voltage with low on-resistance
- High speed switching with low capacitance
- 175°C operating junction temperature capability
- Ultra fast and robust intrinsic body diode
- Kelvin gate input easing driver circuit design
- AEC-Q101 qualification on-going

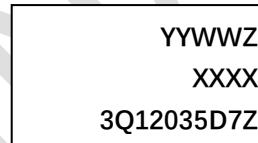
Applications

- EV Motor drivers
- Solar inverters
- High voltage DC/DC converters
- Switch mode power supplies

Outline:



Marking Diagram:



3Q12035D7Z = Specific Device Code
 YY = Year
 WW = Work Week
 Z = Assembly Location
 XXXX = Lot Traceability

Absolute Maximum Ratings ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DS}	Drain-Source voltage	1200	V	$V_{GS}=0V, I_D=100\mu A$	
V_{GSmax} (Transient)	Maximum transient voltage	-10/+23	V	Duty cycle<1%, and pulse width<200ns	
V_{GSon}	Recommended turn-on voltage	15 to 18	V		
V_{GSoff}	Recommended turn-off voltage	-5 to -2	V	Typical -3.5V	
I_D	Drain current (continuous)	63	A	$V_{GS}=18V, T_c=25^\circ\text{C}$	Fig. 23
		36	A	$V_{GS}=18V, T_c=100^\circ\text{C}$	
I_{DM}	Drain current (pulsed)	158	A	Pulse width limited by SOA	Fig. 25, 26
I_{SM}	Body diode current (pulsed)	158	A	Pulse width limited by SOA and dynamic $R_{\theta(j-c)}$	Fig. 25, 26
P_{TOT}	Total power dissipation	326	W	$T_c=25^\circ\text{C}$	Fig. 24
T_{stg}	Storage temperature range	-55 to 175	$^\circ\text{C}$		
T_J	Operating junction temperature	-55 to 175	$^\circ\text{C}$		
T_L	Solder Temperature	260	$^\circ\text{C}$	wave soldering only allowed at leads, 1.6mm from case for 10 s	

Thermal Data

Symbol	Parameter	Value	Unit	Note
$R_{\theta(j-c)}$	Thermal Resistance from Junction to Case	0.46	$^\circ\text{C/W}$	Fig. 25

Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value			Unit	Test Conditions	Note
		Min.	Typ.	Max.			
I_{DSS}	Zero gate voltage drain current		5	100	μA	$V_{DS}=1200\text{V}, V_{GS}=0\text{V}$	
I_{GSS}	Gate leakage current			± 100	nA	$V_{DS}=0\text{V}, V_{GS}=-5\sim 20\text{V}$	
V_{TH}	Gate threshold voltage	2.0	2.8	4.0	V	$V_{GS}=V_{DS}, I_D=8\text{mA}$	Fig. 8, 9
			2.0		V	$V_{GS}=V_{DS}, I_D=8\text{mA}$ @ $T_J=175^\circ\text{C}$	
R_{ON}	Static drain-source on-resistance		35	46	$\text{m}\Omega$	$V_{GS}=18\text{V}, I_D=30\text{A}$ @ $T_J=25^\circ\text{C}$	Fig. 4, 5, 6, 7
			57		$\text{m}\Omega$	$V_{GS}=18\text{V}, I_D=30\text{A}$ @ $T_J=175^\circ\text{C}$	
			45		$\text{m}\Omega$	$V_{GS}=15\text{V}, I_D=30\text{A}$ @ $T_J=25^\circ\text{C}$	
			61		$\text{m}\Omega$	$V_{GS}=15\text{V}, I_D=30\text{A}$ @ $T_J=175^\circ\text{C}$	
C_{iss}	Input capacitance		2082		pF	$V_{DS}=800\text{V}, V_{GS}=0\text{V},$ $f=100\text{kHz}, V_{AC}=25\text{mV}$	Fig. 16
C_{oss}	Output capacitance		95		pF		
C_{rss}	Reverse transfer capacitance		3		pF		
E_{oss}	C_{oss} stored energy		40		μJ		Fig. 17
Q_g	Total gate charge		83		nC	$V_{DS}=800\text{V}, I_D=30\text{A},$ $V_{GS}=-3\text{ to }18\text{V}$	Fig. 18
Q_{GS}	Gate-source charge		23.5		nC		
Q_{gd}	Gate-drain charge		21		nC		
R_g	Gate input resistance		2.5		Ω	$f=1\text{MHz}$	
E_{ON}	Turn-on switching energy		463.2		μJ	$V_{DS}=800\text{V}, I_D=40\text{A},$ $V_{GS}=-3.5\text{ to }18\text{V},$ $R_{G(\text{ext})}=2.0\Omega,$ $L=200\mu\text{H}$ $T_J=25^\circ\text{C}$	Fig. 19, 20
E_{OFF}	Turn-off switching energy		44.7		μJ		
$t_{d(\text{on})}$	Turn-on delay time		9.5		ns		
t_r	Rise time		13.5				
$t_{d(\text{off})}$	Turn-off delay time		15.9				
t_f	Fall time		6.7				
E_{ON}	Turn-on switching energy		689.7		μJ	$V_{DS}=800\text{V}, I_D=40\text{A},$ $V_{GS}=-3.5\text{ to }18\text{V},$ $R_{G(\text{ext})}=2.0\Omega,$ $L=200\mu\text{H}$ $T_J=175^\circ\text{C}$	Fig. 22
E_{OFF}	Turn-off switching energy		43.9		μJ		

Reverse Diode Characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value			Unit	Test Conditions	Note
		Min.	Typ.	Max.			
V_{SD}	Diode forward voltage		4.3		V	$I_{SD}=30\text{A}, V_{GS}=0\text{V}$	Fig. 10, 11, 12
			4.0		V	$I_{SD}=30\text{A}, V_{GS}=0\text{V}, T_J=175^\circ\text{C}$	
I_S	Diode forward current (continuous)			63	A	$V_{GS}=-2\text{V}, T_c=25^\circ\text{C}$	
				36	A	$V_{GS}=-2\text{V}, T_c=100^\circ\text{C}$	
t_{rr}	Reverse recovery time		34.1		ns	$V_{GS}=-3.5\text{V}/+18\text{V}, I_{SD}=40\text{A}, V_R=800\text{V}, R_{G(\text{ext})}=15\Omega, L=200\mu\text{H}, di/dt=3000\text{A}/\mu\text{s}$	
Q_{rr}	Reverse recovery charge		254		nC		
I_{RRM}	Peak reverse recovery current		22.4		A		

Typical Performance (curves)

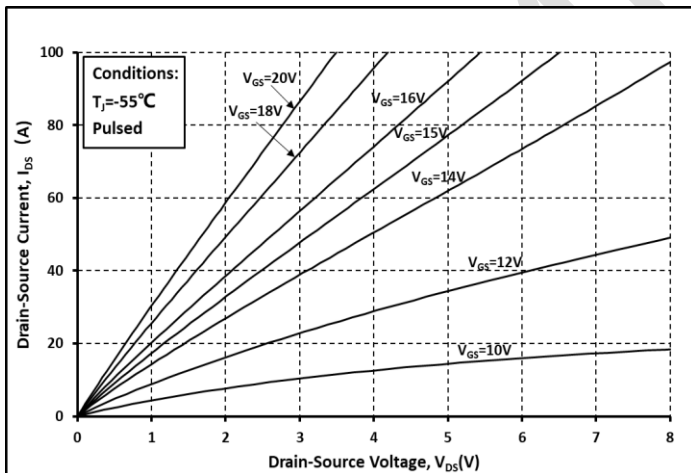


Fig. 1 Output Curve @ $T_J=-55^\circ\text{C}$

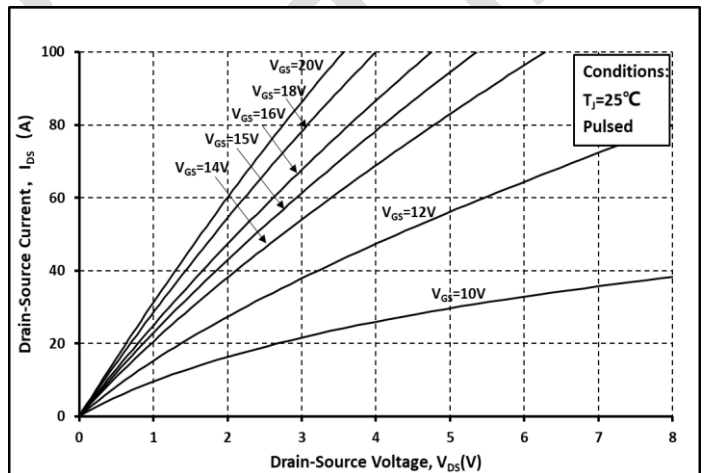


Fig. 2 Output Curve @ $T_J=25^\circ\text{C}$

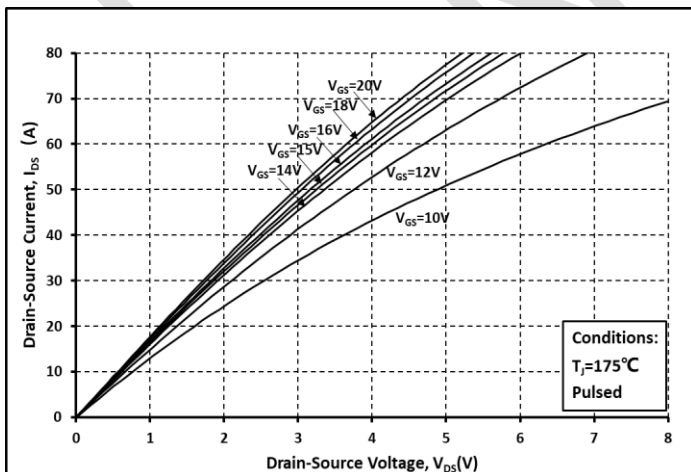


Fig. 3 Output Curve @ $T_J=175^\circ\text{C}$

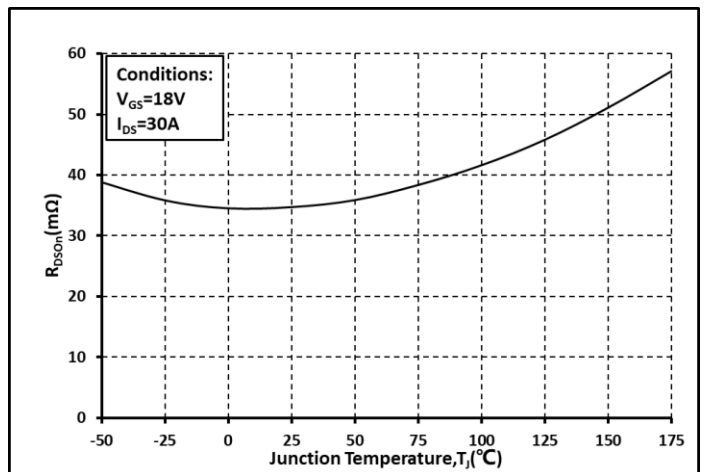


Fig. 4 R_{on} vs. Temperature

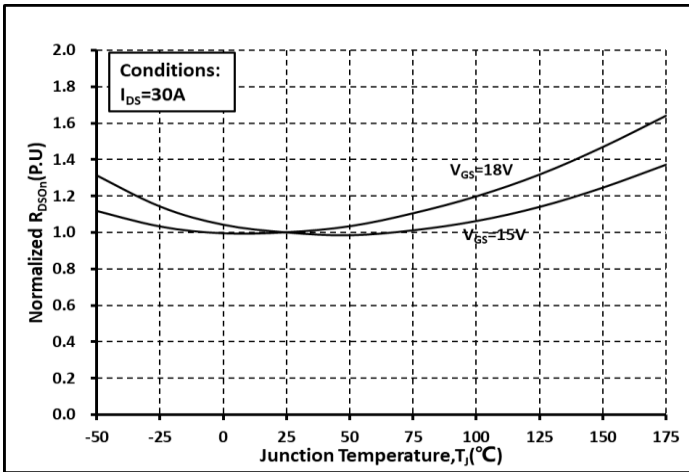


Fig. 5 Normalized Ron vs. Temperature

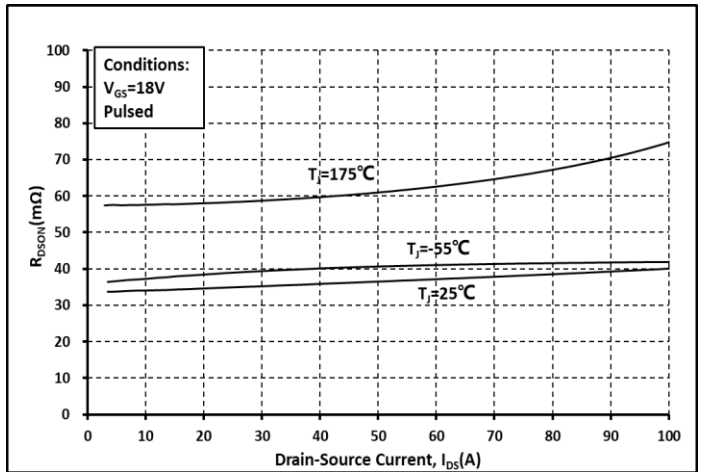


Fig. 6 Ron vs. Ids @ Various Temperature

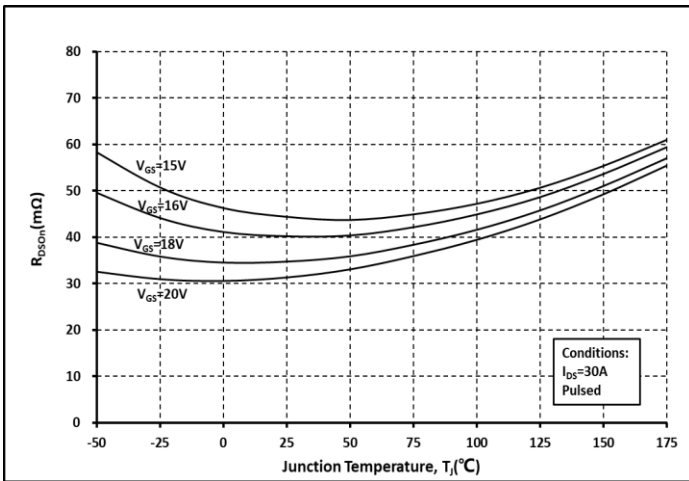


Fig. 7 Ron vs. Temperature @ Various Vgs

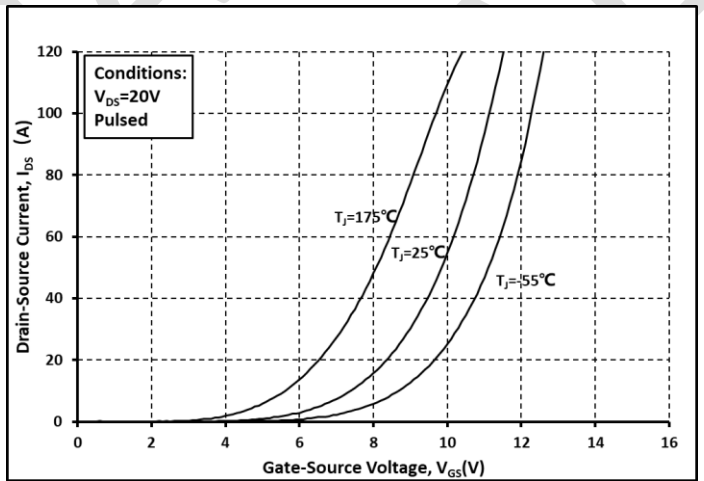


Fig. 8 Transfer Curves @ Various Temperature

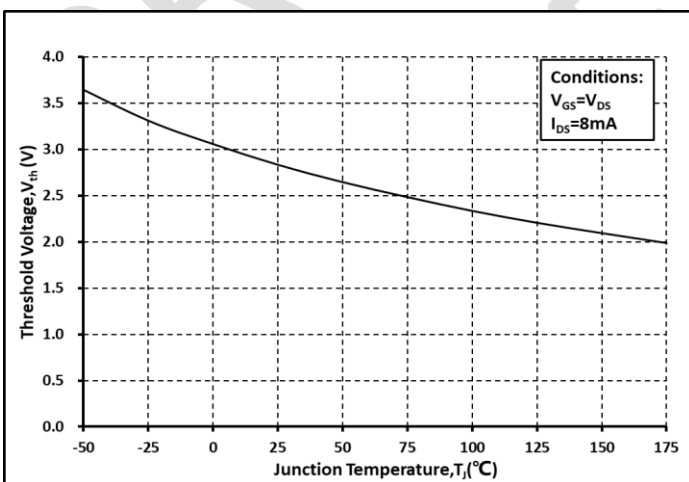


Fig. 9 Threshold Voltage vs. Temperature

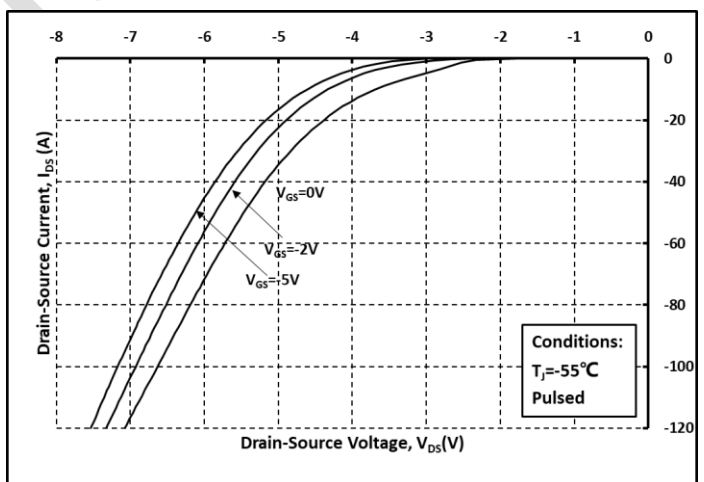


Fig. 10 Body Diode curves @ Tj=-55°C

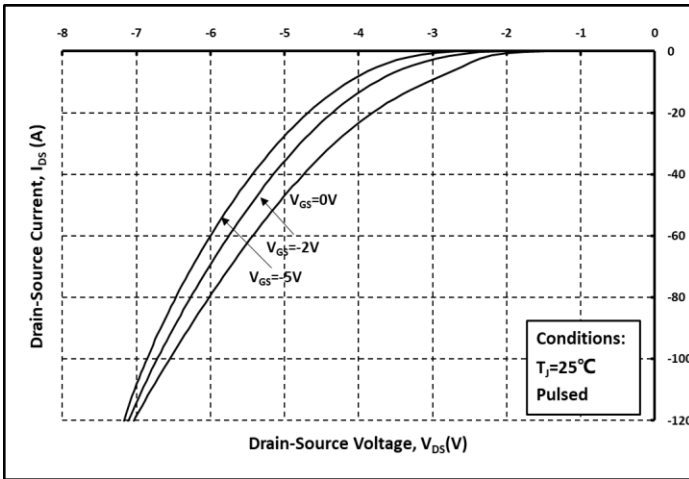


Fig. 11 Body Diode curves @ $T_j=25^\circ\text{C}$

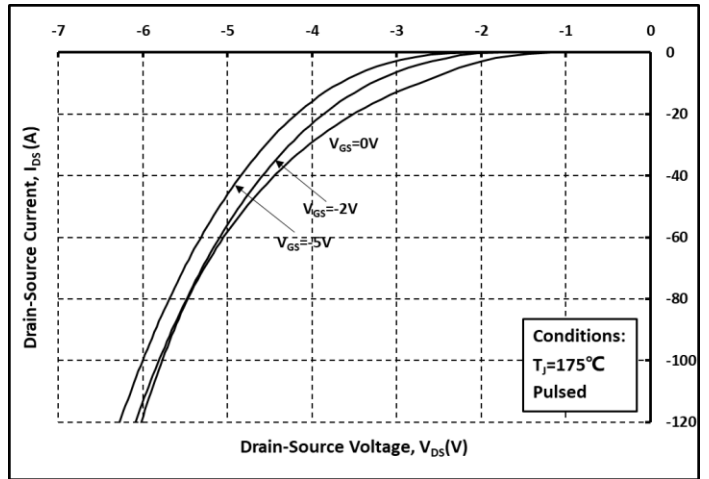


Fig. 12 Body Diode curves @ $T_j=175^\circ\text{C}$

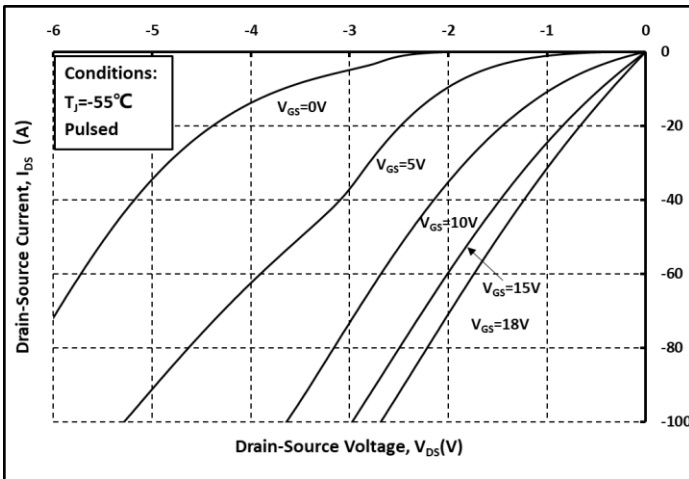


Fig. 13 3rd Quadrant curves @ $T_j=-55^\circ\text{C}$

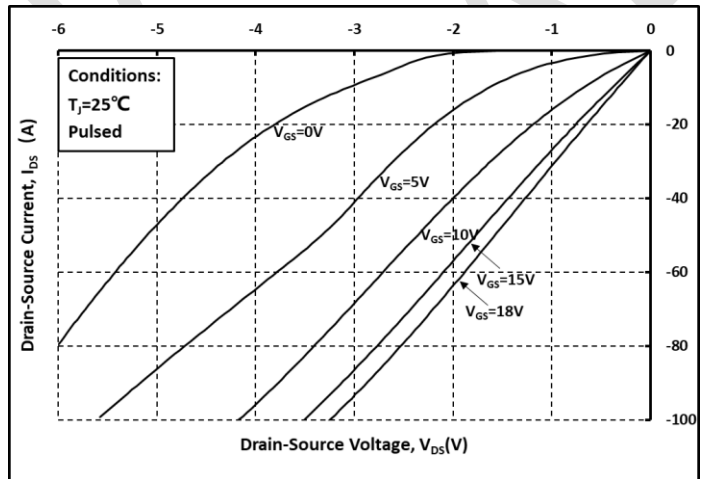


Fig. 14 3rd Quadrant curves @ $T_j=25^\circ\text{C}$

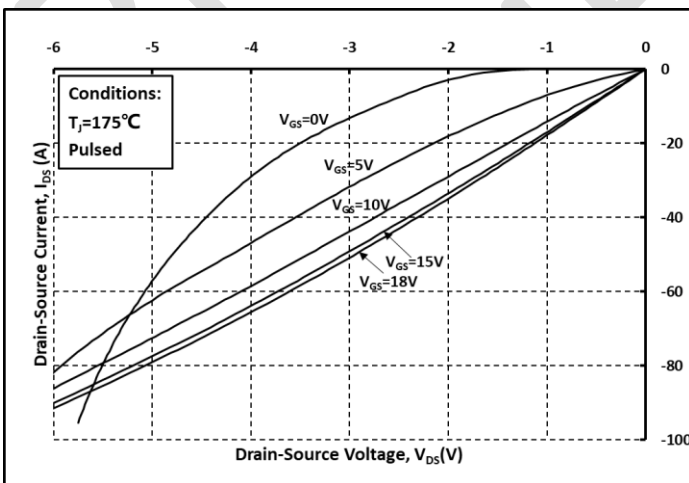


Fig. 15 3rd Quadrant curves @ $T_j=175^\circ\text{C}$

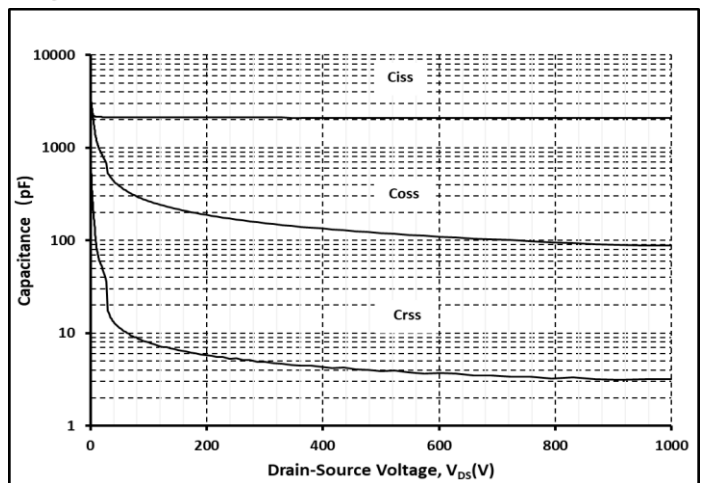


Fig. 16 Capacitance vs. V_{ds}

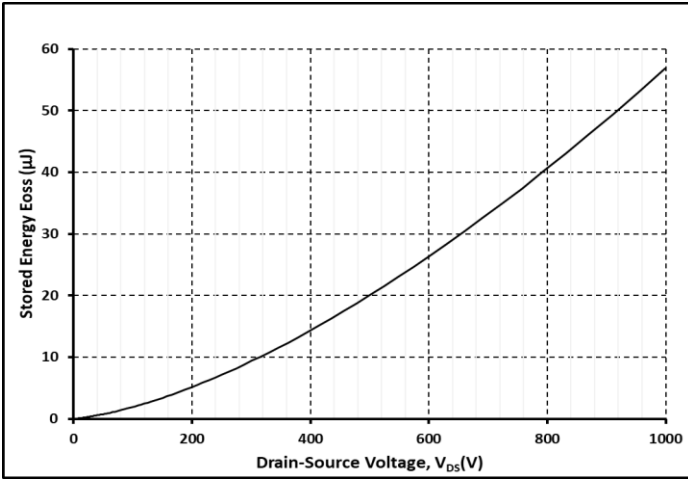


Fig. 17 Output Capacitor Stored Energy

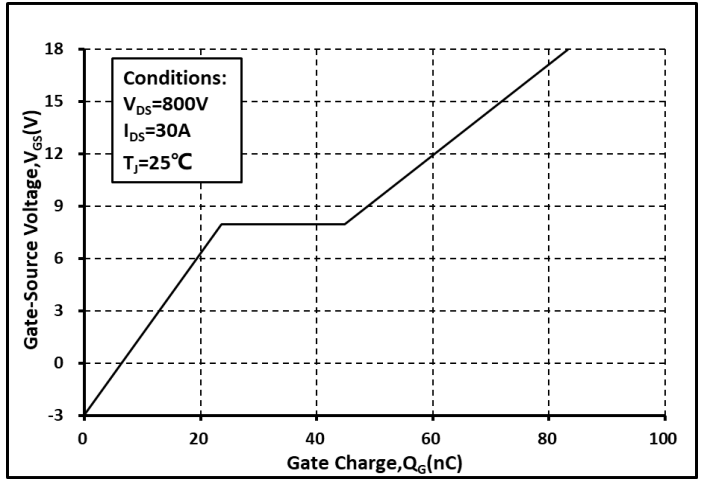


Fig. 18 Gate Charge Characteristics

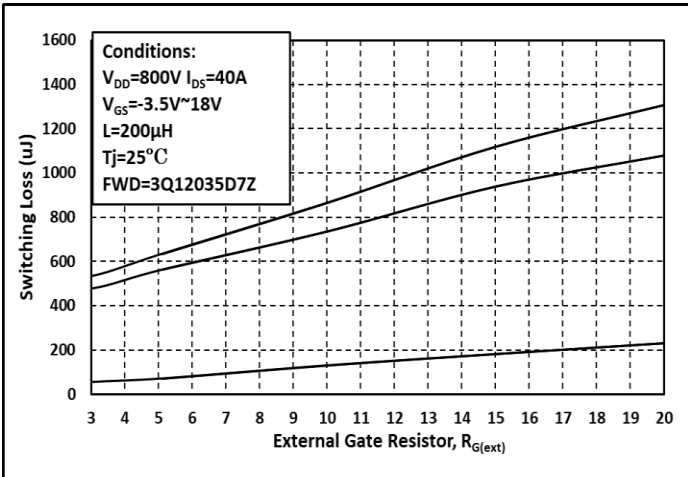


Fig. 19 Switching Energy vs. $R_{G(ext)}$

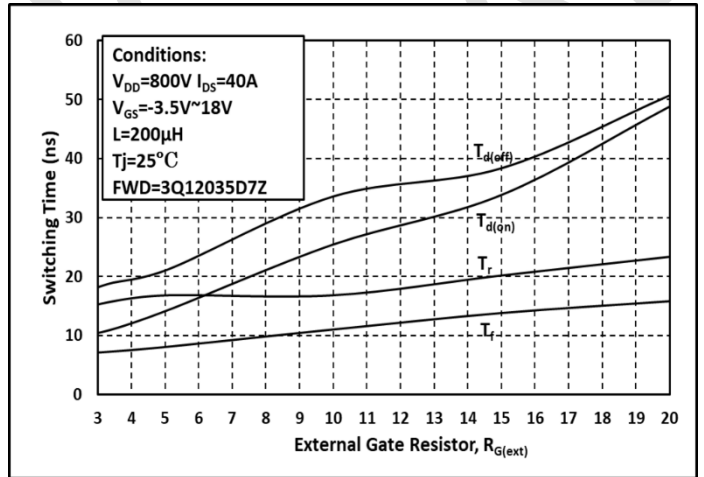


Fig. 20 Switching Times vs. $R_{G(ext)}$

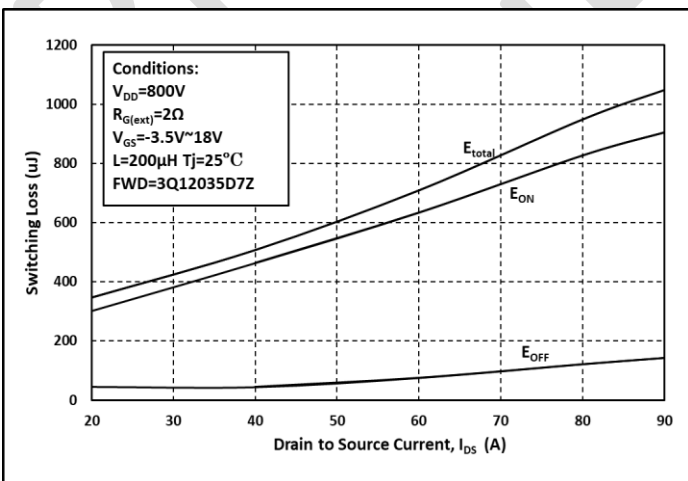


Fig. 21 Switching Energy vs. I_{DS}

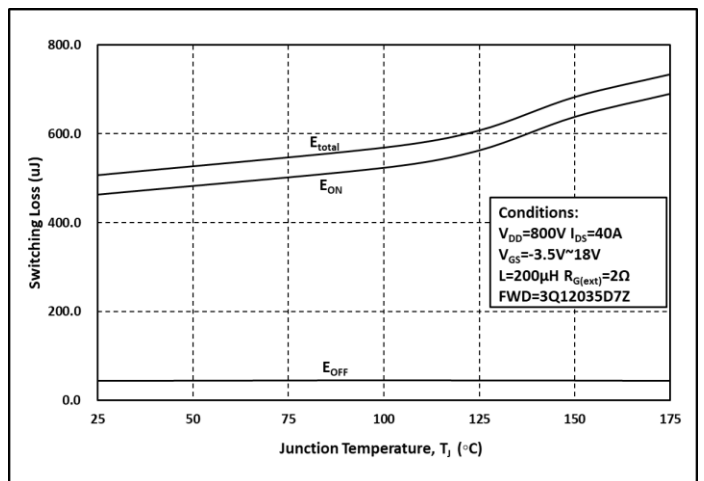


Fig. 22 Switching Energy vs. Temperature

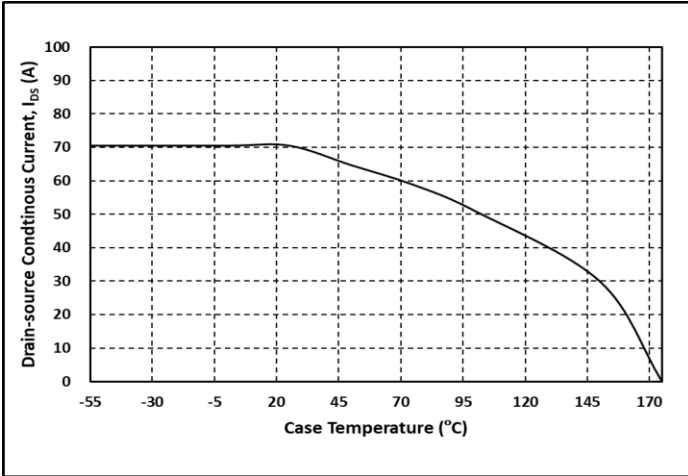


Fig. 23 Continuous Drain Current vs. Case Temperature

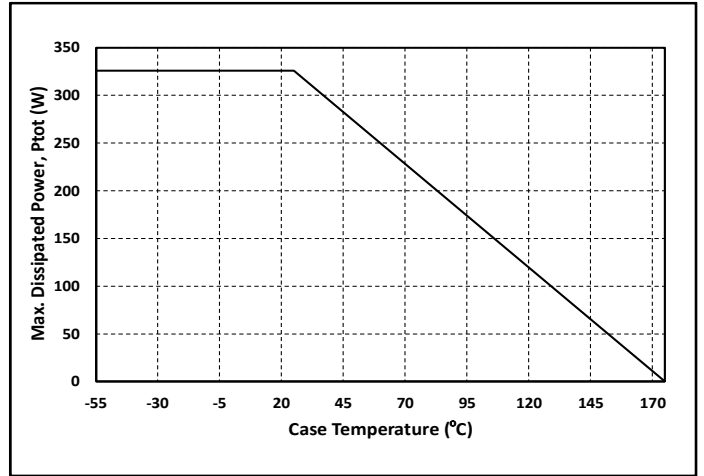


Fig. 24 Max. Power Dissipation Derating vs. Case Temperature

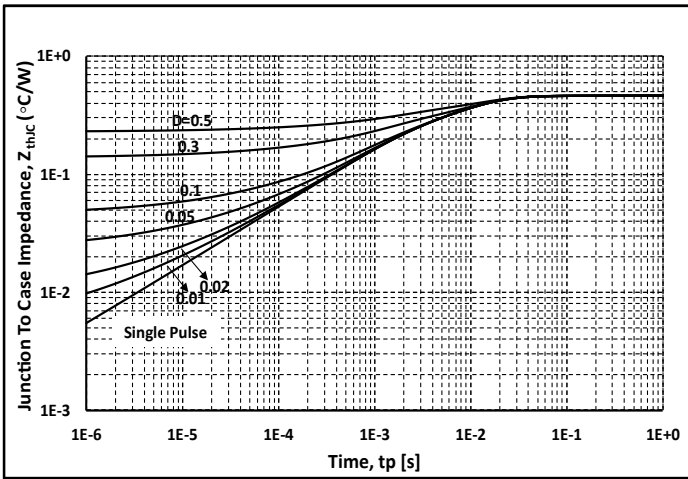


Fig. 25 Thermal impedance

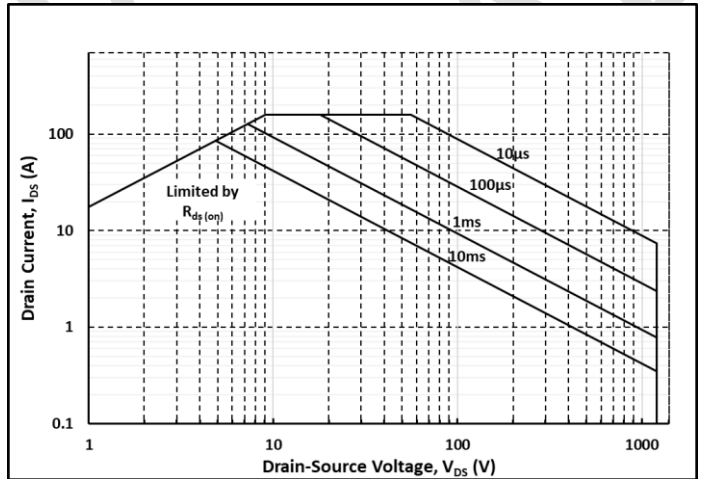
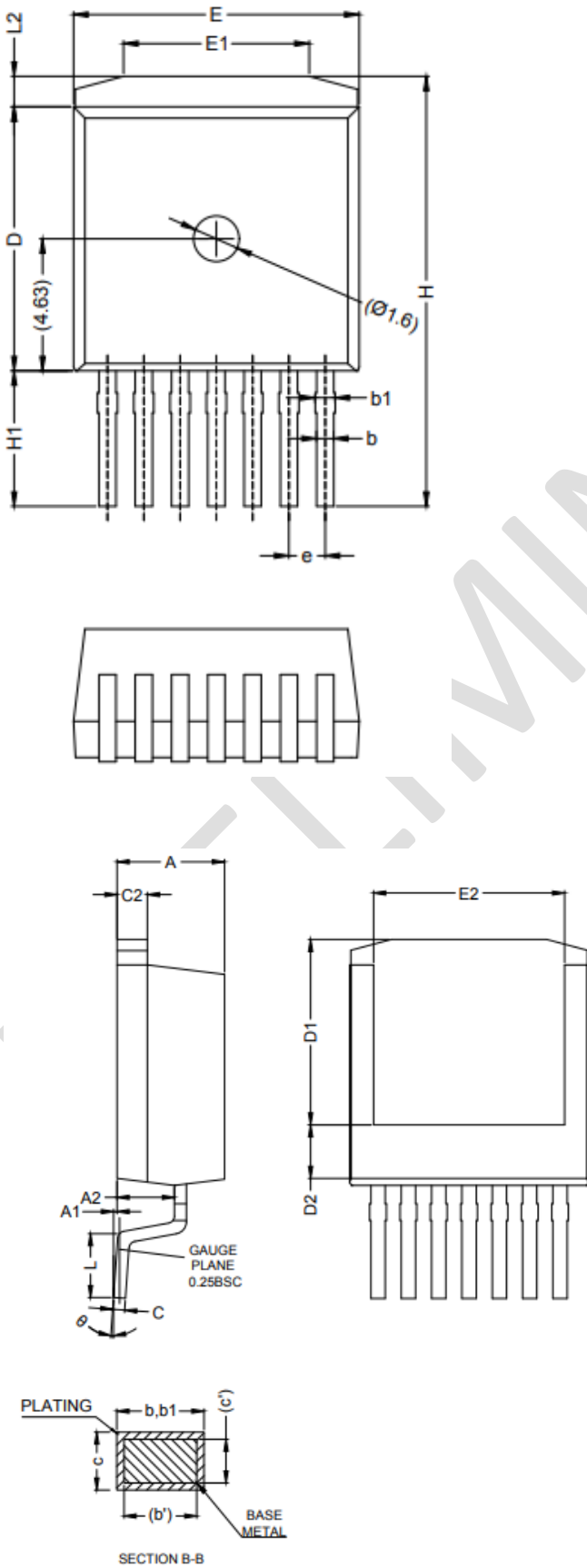


Fig. 26 Safe Operating Area

Package Dimensions



Items	Min	Max
A	4.30	4.70
A1	-	0.25
A2	2.20	2.60
b	0.52	0.72
b'	0.50	0.70
b1	0.60	0.80
c	0.42	0.62
c'	0.40	0.60
c2	1.07	1.47
D	9.05	9.45
D1	7.58	7.98
D2	2.05	2.45
e	1.27 BSC	
E	9.80	10.20
E1	6.30	6.70
E2	7.80	8.20
L	2.48	2.88
L2	0.87	1.27
H	14.87	15.27
H1	4.55	4.95
θ	0°	8°

Note:

1. Package Reference: JEDEC TO263, Variation AD
2. All Dimensions are in mm
3. Subject to Change Without Notice

Notes

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